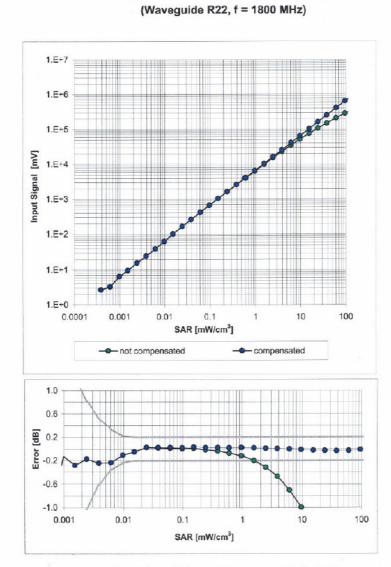


ET3DV6 SN:1788

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Dynamic Range f(SAR_{head})

Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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ET3DV6 SN:1788

3.5 3.0

2.5

2.0 1.5

1.0

0.5

0

-O-Analytical

SAR[mW/cm³] / W

f = 900 MHz, WGLS R9 (head)

20

40

----- Measurements

z[mm]

60

f = 1750 MHz, WGLS R22 (head) 15.0 10.0 10.0 20 40 60 z[mm]

Conversion Factor Assessment

f [MHz]	Validity [MHz] ^C	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	1.12	1.42	6.74 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	1.07	1.44	6.63 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.56	2.31	5.37 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.55	2.42	5.16 ± 11.0% (k=2)
2000	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.54	2.59	4.88 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.65	2.22	4.56 ± 11.8% (k=2)
835	± 50/±100	Body	55.2 ± 5%	0.97 ± 5%	1.04	1.52	6.53 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.99	1.56	6.17 ± 11.0% (k=2)
1750	± 50/±100	Body	53.3 ± 5%	1.52 ± 5%	0.53	2.74	4.73 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.55	2.82	4.56 ± 11.0% (k=2)
2000	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.54	2.98	4.43 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.72	2.00	4.26 ± 11.8% (k=2)

^c The validity of \pm 100 MHz only applies for DASY 4.3 B17 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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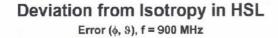
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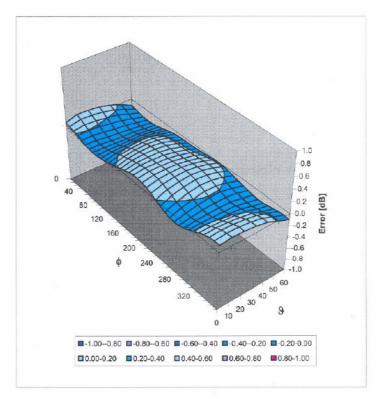
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Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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Accredited by the Swiss Federal Off The Swiss Accreditation Service i Multilateral Acceement for the rec		Accreditation N	o.: SCS 108
Multilatoral Acroomont for the rec	-	to the EA	0
	ognition of calibration c		
Client Sporton (Auden)	Certificate No:	DAE3-577_Nov05
CALIBRATION C	ERTIFICATE		
Object	DAE3 - SD 000 D	03 AA - SN: 577	
Calibration procedure(s)	QA CAL-06.v12		
	Calibration procee	lure for the data acquisition electr	onics (DAE)
Calibration date:	November 11, 200	05	
Condition of the calibrated item	In Tolerance		
The measurements and the uncertainty	ainties with confidence pro	anal standards, which realize the physical units obability are given on the following pages and r facility: environment temperature $(22 \pm 3)^{\circ}$ C at	are part of the certificate.
The measurements and the uncertainty	ainties with confidence pro ed in the closed laboratory	obability are given on the following pages and	are part of the certificate. and humidity < 70%.
The measurements and the uncert All calibrations have been conducts Calibration Equipment used (M&TE Primary Standards	ainties with confidence pro- ed in the closed laboratory E critical for calibration)	obability are given on the following pages and r facility: environment temperature (22 ± 3)°C a Cal Date (Calibrated by, Certificate No.)	are part of the certificate. and humidity < 70%. Scheduled Calibration
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The measurements and the uncert All calibrations have been conducts Calibration Equipment used (M&TE Primary Standards	ainties with confidence pro- ed in the closed laboratory E critical for calibration)	obability are given on the following pages and r facility: environment temperature (22 ± 3)°C a Cal Date (Calibrated by, Certificate No.)	are part of the certificate. and humidity < 70%. Scheduled Calibration
The measurements and the uncert All calibrations have been conducts Calibration Equipment used (M&TE Primary Standards Fluke Process Calibrator Type 702	ainties with confidence pro- ed in the closed laboratory E critical for calibration) ID # SN: 6295803 ID #	bability are given on the following pages and facility: environment temperature (22 ± 3)°C a Cal Date (Calibrated by, Certificate No.) 7-Oct-05 (Sintrel, No.E-050073)	are part of the certificate. and humidity < 70%. Scheduled Calibration Oct-05
The measurements and the uncert All calibrations have been conducts Calibration Equipment used (M&TE Primary Standards Fluke Process Calibrator Type 702 Secondary Standards	ainties with confidence pro- ed in the closed laboratory E critical for calibration) ID # SN: 6295803 ID #	cbability are given on the following pages and reacility: environment temperature (22 ± 3)°C a <u>Cal Date (Calibrated by, Certificate No.)</u> 7-Oct-05 (Sintrel, No.E-050073) Check Date (In house)	are part of the certificate. and humidity < 70%. Scheduled Calibration Oct-06 Scheduled Check
The measurements and the uncert All calibrations have been conducts Calibration Equipment used (M&TE Primary Standards Fluke Process Calibrator Type 702 Secondary Standards	ainties with confidence pro- ed in the closed laboratory E critical for calibration) ID # SN: 6295803 ID #	cbability are given on the following pages and reacility: environment temperature (22 ± 3)°C a <u>Cal Date (Calibrated by, Certificate No.)</u> 7-Oct-05 (Sintrel, No.E-050073) Check Date (In house)	are part of the certificate. and humidity < 70%. Scheduled Calibration Oct-06 Scheduled Check
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The measurements and the uncert All calibrations have been conducts Calibration Equipment used (M&TE Primary Standards Fluke Process Calibrator Type 702 Secondary Standards	ainties with confidence pro- ed in the closed laboratory E critical for calibration) ID # SN: 6295803 ID # SE UMS 006 AB 1002	cbability are given on the following pages and r facility: environment temperature (22 ± 3)°C at <u>Cal Date (Calibrated by, Certificate No.)</u> 7-Oct-05 (Sintrel, No.E-050073) <u>Check Date (in house)</u> 29-Jun-05 (SPEAG, in house check)	are part of the certificate. and humidity < 70%. Scheduled Calibration Oct-05: Scheduled Check In house check Jun-06
The measurements and the uncert All calibrations have been conducts Calibration Equipment used (M&TE Primary Standards Fluke Process Calibrator Type 702 Secondary Standards Calibrator Box V1.1	ainties with confidence pro- ed in the closed laboratory E critical for calibration) ID # SN: 6295803 ID # SE UMS 006 AB 1002 Name	Cal Date (Calibrated by, Certificate No.) 7-Oct-05 (Sintrel, No.E-050073) Check Date (In house) 29-Jun-05 (SPEAG, in house check)	are part of the certificate. and humidity < 70%. <u>Scheduled Calibration</u> Oct-05: <u>Scheduled Check</u> In house check Jun-06 Signature
The measurements and the uncert All calibrations have been conducts Calibration Equipment used (M&TE Primary Standards Fluke Process Calibrator Type 702 Secondary Standards	ainties with confidence pro- ed in the closed laboratory E critical for calibration) ID # SN: 6295803 ID # SE UMS 006 AB 1002	cbability are given on the following pages and r facility: environment temperature (22 ± 3)°C at <u>Cal Date (Calibrated by, Certificate No.)</u> 7-Oct-05 (Sintrel, No.E-050073) <u>Check Date (in house)</u> 29-Jun-05 (SPEAG, in house check)	are part of the certificate. and humidity < 70%. Scheduled Calibration Oct-05: Scheduled Check In house check Jun-06
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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Schweizerischer Kalibrierdienst Service suisse d'étalonnage С Servizio svizzero di taratura S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE Connector angle

data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the . nominal calibration voltage. Influence of offset voltage is included in this measurement.
- Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
- Channel separation: Influence of a voltage on the neighbor channels not subject to an input . voltage.
- · AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
- Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
- Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
- Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
- Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Res	olution nominal			
High Range:	1LSB =	6.1µV,	full range =	-100+300 mV
Low Range:	1LSB =	61nV,	full range =	-1+3mV
DASY measurement	parameters: Auto	o Zero Time: 3	sec; Measuring f	time: 3 sec

Calibration Factors	х	Y	Z
High Range	$404.445 \pm 0.1\%$ (k=2)	403.896 ± 0.1% (k=2)	$404.369 \pm 0.1\%$ (k=2)
Low Range	$3.94241 \pm 0.7\%$ (k=2)	3.89919 ± 0.7% (k=2)	3.95427 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	130 ° ± 1 °
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Appendix

1. DC Voltage Linearity

High Range		Input (µV)	Reading (µV)	Error (%)
Channel X	+ Input	200000	199999.3	0.00
Channel X	+ Input	20000	20006.75	0.03
Channel X	- Input	20000	-19997.90	-0.01
Channel Y	+ Input	200000	200000.3	0.00
Channel Y	+ Input	20000	20004.58	0.02
Channel Y	- Input	20000	-20000.75	0.00
Channel Z	+ Input	200000	199999.6	0.00
Channel Z	+ Input	20000	20001.43	0.01
Channel Z	- Input	20000	-20003.93	0.02

Low Range		Input (µV)	Reading (µV)	Error (%)
Channel X	+ Input	2000	2000.1	0.00
Channel X	+ Input	200	200.42	0.21
Channel X	- Input	200	-200.30	0.15
Channel Y	+ Input	2000	2000.1	0.00
Channel Y	+ Input	200	199.35	-0.32
Channel Y	- Input	200	-200.96	0.48
Channel Z	+ Input	2000	1999.9	0.00
Channel Z	+ Input	200	199.37	-0.31
Channel Z	- Input	200	-200.62	0.31

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (µV)
Channel X	200	13.40	12.55
	- 200	-12.29	ć -13.06
Channel Y	200	-6.93	-7.43
	- 200	6.72	6.47
Channel Z	200	0.71	0.36
5	- 200	-1.67	-1.93

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	1.59	0.08
Channel Y	200	1.69	-	3.62
Channel Z	200	-0.73	-1.49	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15946	15679
Channel Y	15960	16151
Channel Z	16233	15968

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input 10 M $\!\Omega$

	Average (µV)	min. Offset (µV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.08	-1.13	2.31	0.51
Channel Y	-0.35	-2.00	0.81	0.43
Channel Z	-0.38	-2.76	1.68	0.40

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	200.8
Channel Y	0.2000	201.4
Channel Z	0.2001	200.3

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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